

Surface functionalization of HF-treated silicon nanowires

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MS received 18 December 2007; revised 11 March 2009

Abstract. Versatile methods were employed to investigate the chemical reactivity of hydrogen-terminated surface of silicon nanowires. The experimental results showed that coupling reaction took place when silicon nanowires reacted with 2,2,2-trifluoroethyl acrylate, and reductive deposition reaction occurred in the presence of inorganic salt such as $HgCl_2$, and also co-reduction reaction took place in a solution containing both $AuCl_3$ and $PdCl_2$. The possible reaction mechanisms were studied and this study would be expected to favour the homogeneity, selectivity, reproducibility, and stability of SiNW devices or sensors.

Keywords. Silicon nanowires; reactivity; mercurous chloride; 2,2,2-trifluoroethyl acrylate; Au-Pd bimetal.

1. Introduction

One-dimensional (1D) nanostructures, such as nanorods, nanowires, nanotubes and nanobelts have been attracting a lot of interests for their unique potential applications.^{1–6} Nanowires are bright members in the various nanostructures because they possess excellent properties such as high aspect ratios, fine flexibility, ease of combination, high sensitivity and selectivity which are perfect for nano-devices and nanosensors. Silicon nanowires (SiNWs) have attracted great attention, because silicon is of great technological importance in microelectronics.⁷ Moreover, SiNWs provide a number of advantages: unique semiconducting, mechanical, optical and field-emission properties,^{8,9} and a vast surface-to-volume ratio.¹⁰ These properties make them particularly appealing in the application of a variety of fields, such as constructing nanoscale electric, optoelectric devices^{11–13} and biological applications: detection of fM level of protein¹⁴ and DNA.¹⁵

Hence, many successful synthesis strategies to obtain bulk quantities of SiNWs have been developed using laser ablation or thermal evaporation of silicon

powder,^{16–19} and solvothermal method,^{20,21} which provide sufficient quantities of SiNWs for the detailed studies of their physical and chemical properties as well as applications.

One of the special interests of SiNWs is that their surfaces can be easily modified to act as both electron-transfer mediator and immobilizing matrices for biological or chemical molecules.²² The chemical properties of SiNWs surfaces are crucial to their application in mesoscopic electronic devices in terms of stability and transport properties. Currently, many studies have been involved in the modification and reactivity of SiNWs. Park *et al* have selectively functionalized the SiNWs via nanoscale Joule heating.²³ Shir *et al* investigated the oxidation of silicon nanowires.²⁴ Leu *et al* have systematically investigated different surface coverage (H, Br, Cl, and I) using *ab initio* density functional theory calculations.²⁵

In this paper, the organic molecule such as 2,2,2-trifluoroethyl acrylate, and inorganic mercurous chloride and the mixture solution of $AuCl_3$ and $PdCl_2$ were taken for the example to study the reactivity of SiNWs, which is an activity agent when refreshed with HF solution. This study on reactivity of SiNWs would be expected to favour the homogeneity, se-

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lecivity, reproducibility, and stability of SiNW devices or sensors.

2. Experimental

SiNWs, prepared as previous report,²⁶ were etched with 5% HF aqueous solution for 5 min, then picked out and sopped up the remanent solution for the following experiments.

2.1 Reaction of SiNWs with 2,2,2-trifluoroethyl acrylate

The as-treated SiNWs were added into and reacted with 2,2,2-trifluoroethyl acrylate ($\text{CH}_2=\text{CHCOOCH}_2\text{CF}_3$) under the irradiation of 270–340 nm UV lamp for 12 h. After sopped up, the as-treated products were put in chloroform under ultrasonic treatment for 10 min to remove unreacted trifluoroethyl acrylate, and then hydrolysed in methanol aqueous solution for another 10 min ultrasonic treatment.

2.2 Reduction deposition of Hg_2Cl_2

The as-treated SiNWs were added into and reacted with HgCl_2 solution until the yellow SiNWs turned dark grey.

2.3 Co-reduction reaction of Au–Pd bimetal

The as-treated SiNWs were immersed in 4 ml mixture solution, which were composed of 2 ml 5×10^{-3} M AuCl_3 aqueous solution and 2 ml 5×10^{-3} M PdCl_2 aqueous solution. When the yellow SiNWs gradually turned black, it indicated that they were modified with Au–Pd bimetal.

2.4 Characterization

The phase purity of the as-prepared products was determined by a Shimadzu XRD-6000 X-ray diffractometer equipped with $\text{CuK}\alpha$ radiation ($\lambda = 0.15406$ nm). A scanning rate of 0.05 s^{-1} was applied to record the pattern. The morphology and nanostructure of the nanocomposites were carried out with a field emission scanning electron microscope (FESEM) (S 4800), transmission electron microscope (TEM) (Hitachi H-800), and a high-resolution transmission electron microscope (HRTEM) (JEOL-2010). X-ray photoelectron spectroscopy (XPS) was

recorded on a VG ESCALAB MK II X-ray photoelectron spectrometer, using non-monochromatized $\text{Al K}\alpha$ X-ray as the excitation source. The binding energy of contaminated carbon (C 1s: 284.6 eV) was used as the reference.

3. Results and discussion

Figure 1a shows the XRD pattern of as-prepared SiNWs, and all diffraction peaks can be indexed as the cubic phase of Si (JCPDS 27-1402). The SEM image (figure 2a) reveals that the sample takes the shape of a wire, which is smooth and with the average diameter of 25 nm. Figure 2b presents a TEM image of SiNWs, which indicates high degree of crystallinity from the bright stripes. HRTEM image (figure 2c) shows clear lattice fringes with distance of 0.318 nm, which correspond to the (111) and (-1–11) planes. The growth direction of the SiNWs is determined as [112].

Figure 3a displays the core level XP spectrum of Si2p which gives the binding energy 103.2 eV. This value is corresponding to that of silicon oxide while the peak at 99.3 eV, which belongs to element Si, is hardly observed. It is because core silicon nanowire is covered with a thick silicon oxide layer. When the SiNWs are etched with HF, the element silicon peak at 99.3 eV emerges (figure 3b), and silicon oxide peak at 103.2 eV disappears. These results indicate a silicon oxide layer covered on the SiNWs has been cleared by the HF.

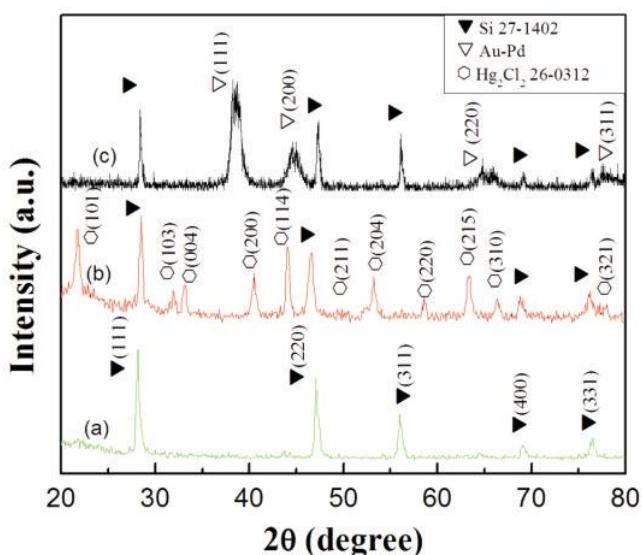


Figure 1. XRD pattern of products: (a) as-prepared Si nanowires. (b) SiNWs supported Hg_2Cl_2 . (c) SiNWs supported Au–Pd bimetal.

3.1 Reaction between SiNWs and $\text{CH}_2=\text{CHCOOCH}_2\text{CF}_3$

Organic-modification is in favour of the biological detection expert for the stabilization of ultrafine parti-

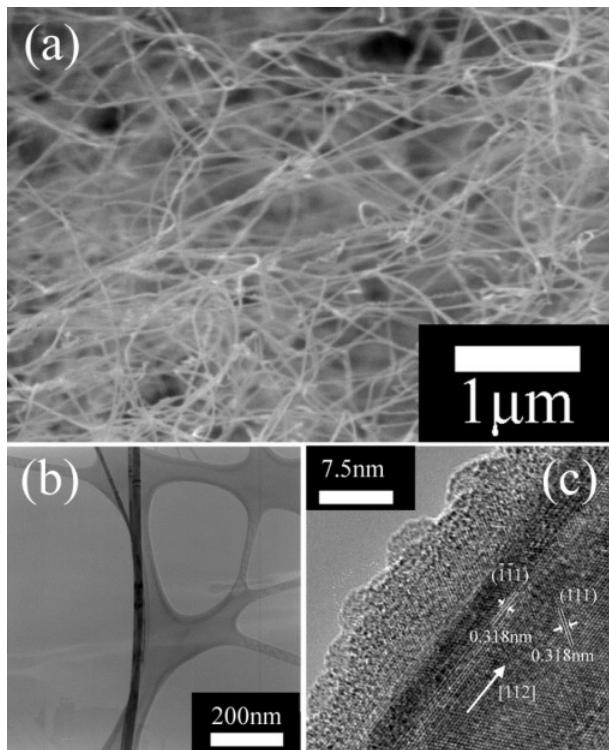


Figure 2. (a) SEM image of as-prepared SiNWs with the average diameter of 25 nm. (b) TEM image of as-prepared SiNWs. (c) HRTEM image showing (111) and ($-1-11$) planes of SiNWs, and the growth direction is determined as [112].

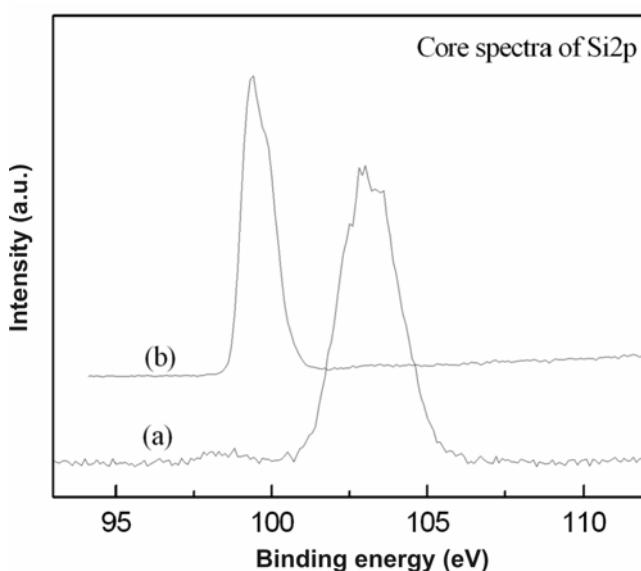


Figure 3. Core spectra of Si2p of SiNWs: (a) before treated with HF, and (b) after treated with HF.

cles. The surface coupling reaction and ester hydrolysis of SiNWs are studied with XPS analysis. 2,2,2-trifluoroethyl acrylate is designed to react with the surface of HF-treated SiNWs, the C_{1s} signal from the trifluoroethyl group is strong and well resolved from other XPS signals, which provides an obvious proof for hydrolysis reaction. The C_{1s} signal is strong after the surface reaction and is completely removed by the hydrolysis procedure, proving that the trifluoroethyl group is linked on the surface of SiNWs and then removed away during the modification.

The carbon core spectra (figure 4a) shows peaks at 287.5 and 293.0 eV assigned to the carbons in trifluoroethyl group.²⁷ And the peaks of the carbonyl carbon and the bulk carbons have been assigned to at 289.3 and 284.4 eV, respectively. After hydrolysis, the carbon peaks at 287.5 and 293.0 eV disappear (figure 4b), which confirmed the complete hydrolysis of the ester. In contrast, the XPS signals corresponding to the alkyl chain and carboxylic acid group still exist, demonstrating that the linkage between the alkyl chain and the surface was not disrupted by the hydrolysis reaction. The reaction of the modifying process is as given below:

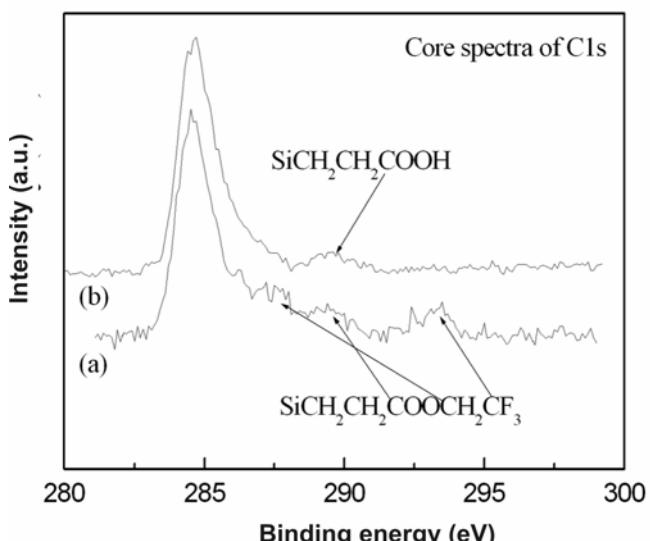
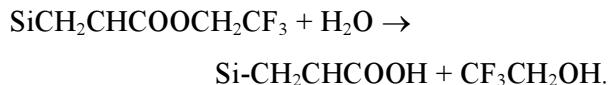
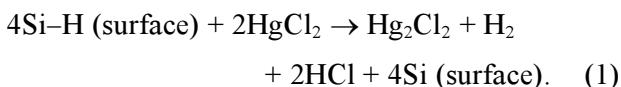


Figure 4. XPS core spectra of C1s of SiNWs: (a) reacted with trifluoroethyl acrylate; and (b) hydrolysed in alcohol aqueous solution.

3.2 Reaction between SiNWs and HgCl₂

Figure 1b shows the XRD pattern of the resultant, coming from the reaction between treated SiNWs and HgCl₂. The diffraction peaks can be indexed to Hg₂Cl₂ (JCPDS 26-0312) besides silicon (JCPDS 27-1402), indicating that the reaction between treated SiNWs and HgCl₂ is a reduction reaction. Figure 5 displays a TEM image of one single wire modified with Hg₂Cl₂, which elucidates that the reduction reaction took place on the surface of SiNWs.

The probable reaction mechanism might be written as follows: first, the oxides on the surface of SiNWs are removed with HF. Then, the hydrogen atom–silicon interaction leads to the formation of surface hydrides (from monohydride to trihydride).²⁸ Last, upon the reaction with HgCl₂, Si–H bond is intimately in the reaction yielding H₂ and Hg₂Cl₂. It reveals that SiNWs is a modest reducing agent when refreshed with HF solution. The reduction reaction can be briefly described as:



This reactivity of SiNWs might be applied in the detection and the wastewater treatment.

3.3 Reaction between SiNWs and PdCl₂ and AuCl₃

Because of the excellent catalysis of Au–Pd bimetal, the coreduction reaction was carried out using the mixture of PdCl₂ and AuCl₃. Figure 1c shows the X-ray diffraction (XRD) pattern of the SiNW-supported Au–Pd nanoparticles. No other characteristic peaks were observed except for Si (JCPDS 27-1402) and Au–Pd bimetal, which indicates that the

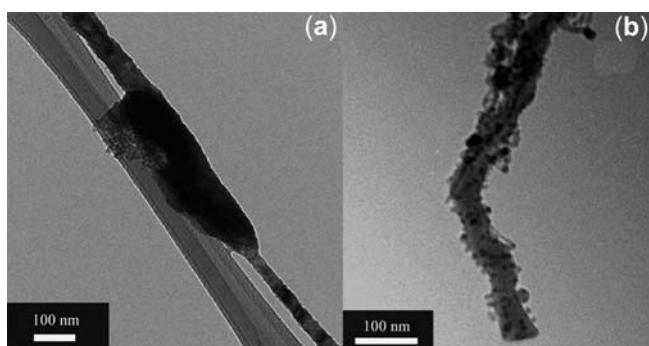


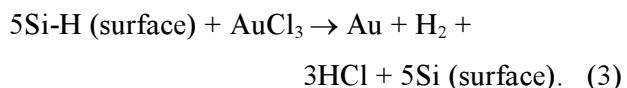
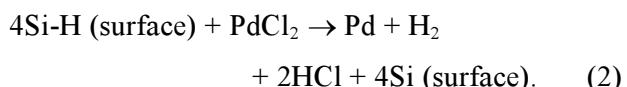
Figure 5. TEM image of one single wire (a) modified with Hg₂Cl₂, (b) supported with Au–Pd bimetal.

product has high purity. A peak between the characteristic peak of Au ($2\theta = 38.2$) (JCPDS 04-0784) and that of Pd ($2\theta = 40.1$) (JCPDS 46-1043), further pointing that Au–Pd bimetallic system was present with the Au : Pd atomic ratio of 2 : 1 calculated according to Vegard's law.²⁹

Figure 5b presents a TEM image of one single wire supported with Au–Pd bimetal, which are randomly attached to the surface of SiNW, taking an average diameter of 8 nm.

The above characterization results are consistent with each other and prove that the Au–Pd bimetal have been co-reduced simultaneously due to the activity of the surface of treated SiNWs.

Based on the above reaction mechanism, it could be deduced that the interaction of SiNWs with Pd²⁺ and Au³⁺ ions is a coreduction process, which involves the electrons transfer to the metal ions absorbed on the surface of SiNWs from the Si atom on the surface, meanwhile the Si–H evolves to hydrogen gas simultaneously. The coreduction process is illustrated in the equation:



4. Conclusions

The reactivity of SiNWs was systematically investigated by the reaction with organic and inorganic compounds, which showed HF-treated SiNWs is an activity agent, and an attractive host for other supported compounds. The study on the reaction mechanism is propitious to functionalize the SiNWs. It provides an avenue for the development of devices in which the exquisite binding specificity of biomolecular recognition is directly coupled with semiconductor devices.

Acknowledgements

The financial support from the National Natural Science Foundation of China (20571001), the Education Department (No. 2006KJ006TD) of Anhui Province and Anhui Provincial Natural Science Foundation (070414185) are acknowledged.

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